

<b>Notice of References Cited</b>		Application/Control No. 10/705,222	Applicant(s)/Patent Under Reexamination SEGAWA ET AL.	
		Examiner Dung Nguyen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0051836 A1	03-2004	Jung et al.	349/149
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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